

TOSHIBA Digital Integrated Circuit Silicon Monolithic

TC7WPN3125FK, TC7WPN3125FC

Low Voltage/Low Power 2-Bit Dual Supply Bus Buffer

The TC7WPN3125 is a dual supply, advanced high-speed CMOS 2-bit dual supply voltage interface bus buffer fabricated with silicon gate CMOS technology.

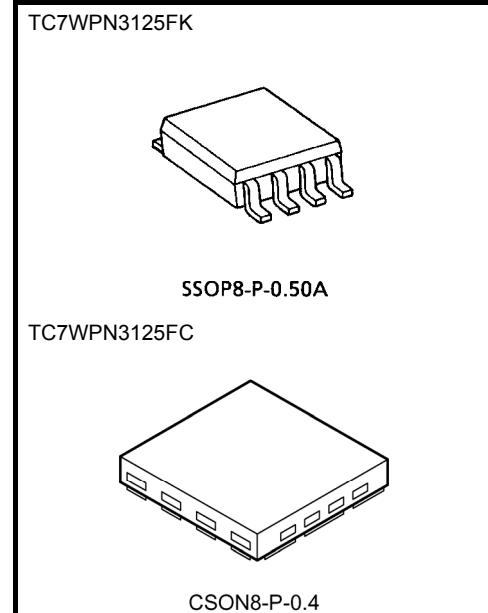
It is also designed with over voltage tolerant inputs and outputs up to 3.6 V.

Designed for use as an interface between a 1.2-V, 1.5-V, 1.8-V, or 2.5-V bus and a 1.8-V, 2.5-V or 3.6-V bus in mixed 1.2-V, 1.5-V, 1.8-V or 2.5-V/1.8-V, 2.5-V or 3.6-V supply systems.

The A-input interfaces with the 1.2-V, 1.5-V, 1.8-V or 2.5-V bus, the B-output with the 1.8-V, 2.5-V, 3.3-V bus.

The enable input (\overline{OE}) can be used to disable the device so that the signal lines are effectively isolated.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

**Weight:**

SSOP8-P-0.50A : 0.01 g (typ.)

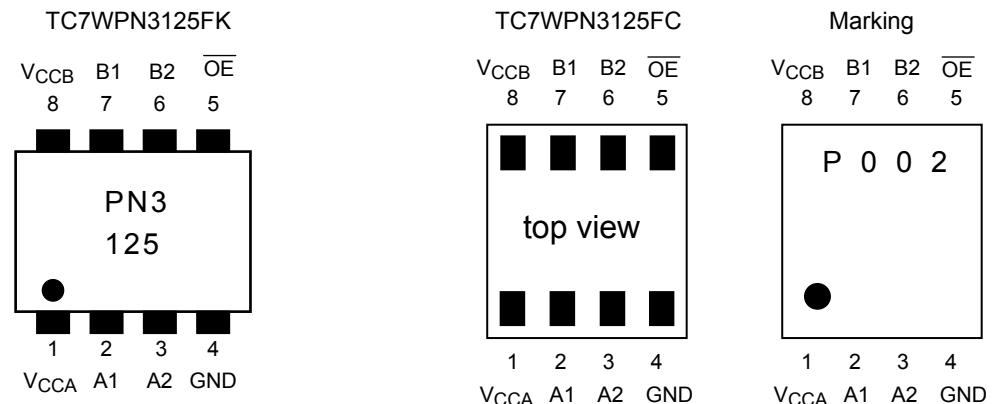
CSON8-P-0.4 : 0.002 g (typ.)

Features

- Level converter for interfacing 1.2-V to 1.8-V, 1.2-V to 2.5-V, 1.2-V to 3.3-V, 1.5-V to 2.5-V, 1.5-V to 3.3-V, 1.8-V to 2.5-V, 1.8-V to 3.3-V or 2.5 V to 3.3-V system.
- High-speed operation : $t_{pd} = 13.7$ ns (max) ($V_{CCA} = 2.5 \pm 0.2$ V, $V_{CCB} = 3.3 \pm 0.3$ V)
 $t_{pd} = 14.8$ ns (max) ($V_{CCA} = 1.8 \pm 0.15$ V, $V_{CCB} = 3.3 \pm 0.3$ V)
 $t_{pd} = 16.0$ ns (max) ($V_{CCA} = 1.5 \pm 0.1$ V, $V_{CCB} = 3.3 \pm 0.3$ V)
 $t_{pd} = 29$ ns (max) ($V_{CCA} = 1.2 \pm 0.1$ V, $V_{CCB} = 3.3 \pm 0.3$ V)
 $t_{pd} = 18.5$ ns (max) ($V_{CCA} = 1.8 \pm 0.15$ V, $V_{CCB} = 2.5 \pm 0.2$ V)
 $t_{pd} = 19.7$ ns (max) ($V_{CCA} = 1.5 \pm 0.15$ V, $V_{CCB} = 2.5 \pm 0.2$ V)
 $t_{pd} = 33$ ns (max) ($V_{CCA} = 1.2 \pm 0.15$ V, $V_{CCB} = 2.5 \pm 0.2$ V)
 $t_{pd} = 43$ ns (max) ($V_{CCA} = 1.2 \pm 0.1$ V, $V_{CCB} = 1.8 \pm 0.15$ V)
- Output current : $IOH/IOL = \pm 3$ mA (min) ($VCC = 3.0$ V)
 $IOH/IOL = \pm 2$ mA (min) ($VCC = 2.3$ V)
 $IOH/IOL = \pm 0.5$ mA (min) ($VCC = 1.65$ V)
- Latch-up performance: -300 mA
- ESD performance: Machine model $\geq \pm 200$ V
Human body model $\geq \pm 2000$ V
- Ultra-small package: CSON8(CST8), SSOP8(US8)
- Low current consumption: Using the new circuit significantly reduces current consumption when $\overline{OE} = "H"$.
Suitable for battery-driven applications such as PDAs and cellular phones.
- 3.6-V tolerant function and power-down protection provided on all inputs and outputs.

Note: Do not apply a signal to any bus pins when it is in the output mode. Damage may result.

Pin Assignment (top view)



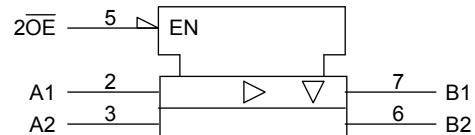
Truth Table

Inputs		Output
\overline{OE}	A1, A2	B1, B2
L	L	L
L	H	H
H	X	Z

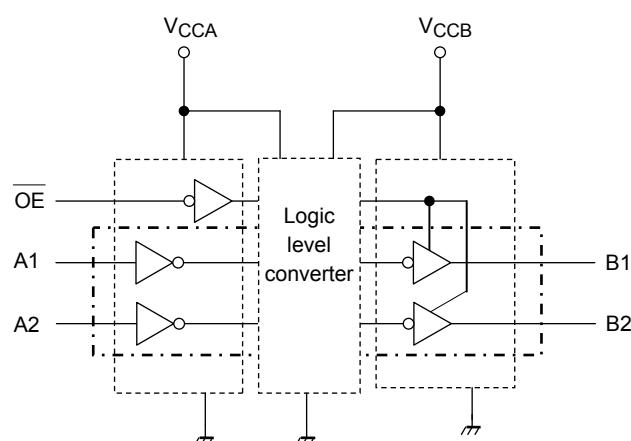
X: Don't care

Z: High impedance

IEC Logic Symbol



Block Diagram



Absolute Maximum Ratings (Note 1)

Characteristics	Symbol	Rating	Unit
Power supply voltage (Note 2)	V _{CCA}	−0.5 to 4.6	V
	V _{CCB}	−0.5 to 4.6	
DC input voltage (An, \overline{OE})	V _{IN}	−0.5 to 4.6	V
DC output voltage (Bn)	V _{OUT}	−0.5 to 4.6 (Note 3)	V
		−0.5 to V _{CCB} + 0.5 (Note 4)	
Input diode current	I _{IK}	−50	mA
Output diode current	I _{OK}	±50 (Note 5)	mA
DC output current	I _{OUTB}	±6	mA
DC V _{CC} /ground current per supply pin	I _{CCA}	±25	mA
	I _{CCB}	±50	
Power dissipation	P _D	150	mW
Storage temperature	T _{stg}	−65 to 150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2: Don't supply a voltage to V_{CCB} pin when V_{CCA} is in the OFF state.

Note 3: Output in OFF state

Note 4: High or Low stats. I_{OUT} absolute maximum rating must be observed.

Note 5: V_{OUT} < GND, V_{OUT} > V_{CC}

Operating Ranges (Note 1)

Characteristics	Symbol	Rating	Unit
Power supply voltage (Note 2)	V _{CCA}	1.1 to 2.7	V
	V _{CCB}	1.65 to 3.6	
Input voltage (An, \overline{OE})	V _{IN}	0 to 3.6	V
Output voltage (Bn)	V _{OUTB}	0 to 3.6 (Note 3)	V
		0 to V _{CCB} (Note 4)	
Output current (Bn)	I _{OUTB}	±3 (Note 5)	mA
		±2 (Note 6)	
		±0.5 (Note 7)	
Operating temperature	T _{opr}	−40 to 85	°C
Input rise and fall time	dt/dv	0 to 10 (Note 8)	ns/V

Note 1: The operating ranges must be maintained to ensure the normal operation of the device.

Unused inputs must be tied to either V_{CC} or GND.

Note 2: Don't use in V_{CCA} > V_{CCB}

Note 3: Output in OFF state

Note 4: High or low state

Note 5: V_{CCB} = 3.0 to 3.6 V

Note 6: V_{CCB} = 2.3 to 2.7 V

Note 7: V_{CCB} = 1.65 to 1.95 V

Note 8: V_{IN} = 0.8 to 2.0 V, V_{CCA} = 2.5 V, V_{CCB} = 3.0 V

Electrical Characteristics

DC Characteristics (1.1 V \leq V_{CCA} \leq 2.7 V, 1.65 V \leq V_{CCB} \leq 3.6 V)

Characteristics	Symbol	Test Condition	V _{CCA} (V)	V _{CCB} (V)	Ta = -40~85°C		Unit
					Min	Max	
H-level input voltage	V _{IHA}	V _{IN}	1.1 \leq V _{CCA} $<$ 1.4	1.65 to 3.6	0.65 \times V _{CCA}	—	V
			1.4 \leq V _{CCA} $<$ 1.65	1.65 to 3.6	0.65 \times V _{CCA}	—	V
			1.65 \leq V _{CCA} $<$ 2.3	2.3 to 3.6	0.65 \times V _{CCA}	—	V
			2.3 \leq V _{CCA} \leq 2.7	2.7 to 3.6	1.6	—	V
L-level input voltage	V _{ILA}	V _{IN}	1.1 \leq V _{CCA} $<$ 1.4	1.65 to 3.6	—	0.30 \times V _{CCA}	V
			1.4 \leq V _{CCA} $<$ 1.65	1.65 to 3.6	—	0.30 \times V _{CCA}	V
			1.65 \leq V _{CCA} $<$ 2.3	2.3 to 3.6	—	0.35 \times V _{CCA}	V
			2.3 \leq V _{CCA} \leq 2.7	2.7 to 3.6	—	0.7	V
H-level output voltage	V _{OHB}	A _n = V _{IH}	I _{OHB} = -100 μ A	1.1 to 1.65	1.65 to 3.6	V _{CCB} - 0.2	V
			I _{OHB} = -0.5mA	1.1 to 1.4	1.65	1.25	
			I _{OHB} = -2 mA	1.1 to 2.3	2.3	1.7	
			I _{OHB} = -3 mA	1.1 to 3.0	3.0	2.2	
L-level output voltage	V _{OLB}	A _n = V _{IL}	I _{OLB} = 100 μ A	1.1 to 1.65	1.65 to 3.6	—	V
			I _{OLB} = 0.5 mA	1.1 to 1.4	1.65	—	
			I _{OLB} = 2 mA	1.1 to 2.3	2.3	—	
			I _{OLB} = 3 mA	1.1 to 3.0	3.0	—	
3-state output OFF state current	I _{OZB}	A _n = V _{IHA} or V _{ILA} B _n = 0~3.6 V		1.1 to 2.7	1.65 to 3.6	—	± 2.0 μ A
Input leakage current	I _{IN}	V _{IN} = 0~3.6 V		1.1 to 2.7	1.65 to 3.6	—	± 1.0 μ A
Power-off leakage current	I _{OFF1}	V _{IN} , B _n = 0~3.6 V		0	0	—	2.0 μ A
	I _{OFF2}	\overline{OE} = V _{CCA}		1.1 to 2.7	0	—	2.0 μ A
	I _{OFF3}	A _n , B _n = 0~3.6 V		1.1 to 2.7	OPEN	—	2.0 μ A
Quiescent supply current	I _{CCA}	V _{IN} = V _{CCA} or GND		1.1 to 2.7	1.65 to 3.6	—	2.0 μ A
	I _{CCB}	V _{IN} = V _{CCA} or GND		1.1 to 2.7	1.65 to 3.6	—	2.0 μ A
	I _{CCA}	V _{CCA} $<$ V _{IN} \leq 3.6 V		1.1 to 2.7	1.65 to 3.6	—	± 2.0 μ A
	I _{CCB}	V _{IN} = V _{CCA} V _{CCB} \leq B _n \leq 3.6 V		1.1 to 2.7	1.65 to 3.6	—	± 2.0 μ A

AC Characteristics (Ta = -40 to 85°C, Input: $t_r = t_f = 2.0$ ns)**V_{CCA} = 2.5 ± 0.2 V, V_{CCB} = 3.3 ± 0.3 V**

Characteristics	Symbol	Test Condition	Min	Max	Unit
Propagation delay time (An → Bn)	t_{pLH} t_{pHL}	Figure 1, Figure 2	1.0	13.7	ns
3-state output enable time (\overline{OE} → Bn)	t_{pZL} t_{pZH}	Figure 1, Figure 3	1.0	16.6	
3-state output disable time (\overline{OE} → Bn)	t_{pLZ} t_{pHZ}	Figure 1, Figure 3	1.0	7.2	
Output to output skew	t_{osLH} t_{osHL}	(Note)	—	0.5	ns

Note: Parameter guaranteed by design.

(tosLH = $|t_{pLHm} - t_{pLHn}|$, tosHL = $|t_{pHLm} - t_{pHLn}|$)**V_{CCA} = 1.8 ± 0.15 V, V_{CCB} = 3.3 ± 0.3 V**

Characteristics	Symbol	Test Condition	Min	Max	Unit
Propagation delay time (An → Bn)	t_{pLH} t_{pHL}	Figure 1, Figure 2	1.0	14.8	ns
3-state output enable time (\overline{OE} → Bn)	t_{pZL} t_{pZH}	Figure 1, Figure 3	1.0	18.9	
3-state output disable time (\overline{OE} → Bn)	t_{pLZ} t_{pHZ}	Figure 1, Figure 3	1.0	8.7	
Output to output skew	t_{osLH} t_{osHL}	(Note)	—	0.5	ns

Note: Parameter guaranteed by design.

(tosLH = $|t_{pLHm} - t_{pLHn}|$, tosHL = $|t_{pHLm} - t_{pHLn}|$)**V_{CCA} = 1.5 ± 0.1 V, V_{CCB} = 3.3 ± 0.3 V**

Characteristics	Symbol	Test Condition	Min	Max	Unit
Propagation delay time (An → Bn)	t_{pLH} t_{pHL}	Figure 1, Figure 2	1.0	16.0	ns
3-state output enable time (\overline{OE} → Bn)	t_{pZL} t_{pZH}	Figure 1, Figure 3	1.0	22.8	
3-state output disable time (\overline{OE} → Bn)	t_{pLZ} t_{pHZ}	Figure 1, Figure 3	1.0	10.2	
Output to output skew	t_{osLH} t_{osHL}	(Note)	—	1.5	ns

Note: Parameter guaranteed by design.

(tosLH = $|t_{pLHm} - t_{pLHn}|$, tosHL = $|t_{pHLm} - t_{pHLn}|$)

$V_{CCA} = 1.2 \pm 0.1 \text{ V}$, $V_{CCB} = 3.3 \pm 0.3 \text{ V}$

Characteristics	Symbol	Test Condition	Min	Max	Unit
Propagation delay time (An → Bn)	t_{pLH} t_{pHL}	Figure 1, Figure 2	1.0	29	ns
3-state output enable time (\overline{OE} → Bn)	t_{pZL} t_{pZH}	Figure 1, Figure 3	1.0	63	
3-state output disable time (\overline{OE} → Bn)	t_{pLZ} t_{pHZ}	Figure 1, Figure 3	1.0	23	
Output to output skew	t_{osLH} t_{osHL}	(Note)	—	1.5	ns

Note: Parameter guaranteed by design.

($t_{osLH} = |t_{pLHm} - t_{pLHn}|$, $t_{osHL} = |t_{pHLm} - t_{pHLn}|$)

$V_{CCA} = 1.8 \pm 0.15 \text{ V}$, $V_{CCB} = 2.5 \pm 0.2 \text{ V}$

Characteristics	Symbol	Test Condition	Min	Max	Unit
Propagation delay time (An → Bn)	t_{pLH} t_{pHL}	Figure 1, Figure 2	1.0	18.5	ns
3-state output enable time (\overline{OE} → Bn)	t_{pZL} t_{pZH}	Figure 1, Figure 3	1.0	23.6	
3-state output disable time (\overline{OE} → Bn)	t_{pLZ} t_{pHZ}	Figure 1, Figure 3	1.0	6.9	
Output to output skew	t_{osLH} t_{osHL}	(Note)	—	0.5	ns

Note: Parameter guaranteed by design.

($t_{osLH} = |t_{pLHm} - t_{pLHn}|$, $t_{osHL} = |t_{pHLm} - t_{pHLn}|$)

$V_{CCA} = 1.5 \pm 0.1 \text{ V}$, $V_{CCB} = 2.5 \pm 0.2 \text{ V}$

Characteristics	Symbol	Test Condition	Min	Max	Unit
Propagation delay time (An → Bn)	t_{pLH} t_{pHL}	Figure 1, Figure 2	1.0	19.7	ns
3-state output enable time (\overline{OE} → Bn)	t_{pZL} t_{pZH}	Figure 1, Figure 3	1.0	26.6	
3-state output disable time (\overline{OE} → Bn)	t_{pLZ} t_{pHZ}	Figure 1, Figure 3	1.0	8.3	
Output to output skew	t_{osLH} t_{osHL}	(Note)	—	1.5	ns

Note: Parameter guaranteed by design.

($t_{osLH} = |t_{pLHm} - t_{pLHn}|$, $t_{osHL} = |t_{pHLm} - t_{pHLn}|$)

$V_{CCA} = 1.2 \pm 0.1 \text{ V}$, $V_{CCB} = 2.5 \pm 0.2 \text{ V}$

Characteristics	Symbol	Test Condition	Min	Max	Unit
Propagation delay time (An → Bn)	t_{pLH} t_{pHL}	Figure 1, Figure 2	1.0	33	ns
3-state output enable time ($\overline{OE} \rightarrow Bn$)	t_{pZL} t_{pZH}	Figure 1, Figure 3	1.0	66	
3-state output disable time ($\overline{OE} \rightarrow Bn$)	t_{pLZ} t_{pHZ}	Figure 1, Figure 3	1.0	20	
Output to output skew	t_{osLH} t_{osHL}	(Note)	—	1.5	ns

Note: Parameter guaranteed by design.

($t_{osLH} = |t_{pLHm} - t_{pLHn}|$, $t_{osHL} = |t_{pHLm} - t_{pHLn}|$)

$V_{CCA} = 1.2 \pm 0.1 \text{ V}$, $V_{CCB} = 1.8 \pm 0.15 \text{ V}$

Characteristics	Symbol	Test Condition	Min	Max	Unit
Propagation delay time (An → Bn)	t_{pLH} t_{pHL}	Figure 1, Figure 2	1.0	43	ns
3-state output enable time ($\overline{OE} \rightarrow Bn$)	t_{pZL} t_{pZH}	Figure 1, Figure 3	1.0	78	
3-state output disable time ($\overline{OE} \rightarrow Bn$)	t_{pLZ} t_{pHZ}	Figure 1, Figure 3	1.0	20	
Output to output skew	t_{osLH} t_{osHL}	(Note)	—	1.5	ns

Note: Parameter guaranteed by design.

($t_{osLH} = |t_{pLHm} - t_{pLHn}|$, $t_{osHL} = |t_{pHLm} - t_{pHLn}|$)

Capacitive Characteristics (Ta = 25°C)

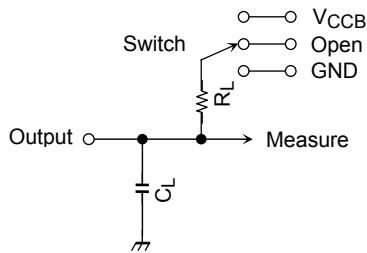
Characteristics	Symbol	Test Circuit	V _{CCA} (V)	V _{CCB} (V)	Typ.	Unit
Input capacitance	C _{IN}	A _n , \overline{OE}	2.5	3.3	7	pF
Output capacitance	C _{OUT}	B _n	2.5	3.3	8	pF
Power dissipation capacitance (Note)	C _{PD} A	/OE="L"	2.5	3.3	3	pF
		/OE="H"	2.5	3.3	0	
	C _{PD} B	/OE="L"	2.5	3.3	13	
		/OE="H"	2.5	3.3	0	

Note: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

$$I_{CC}(\text{opr}) = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/2 \text{ (per bit)}$$

AC Test Circuit

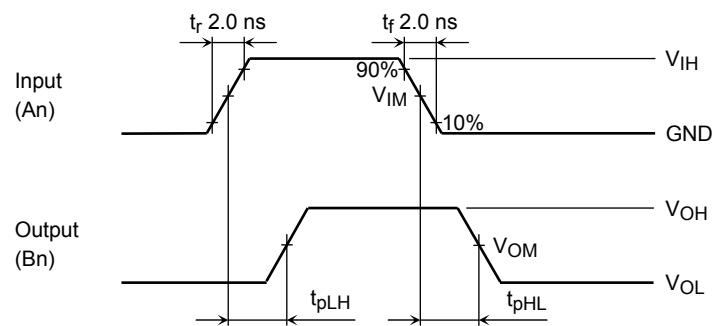
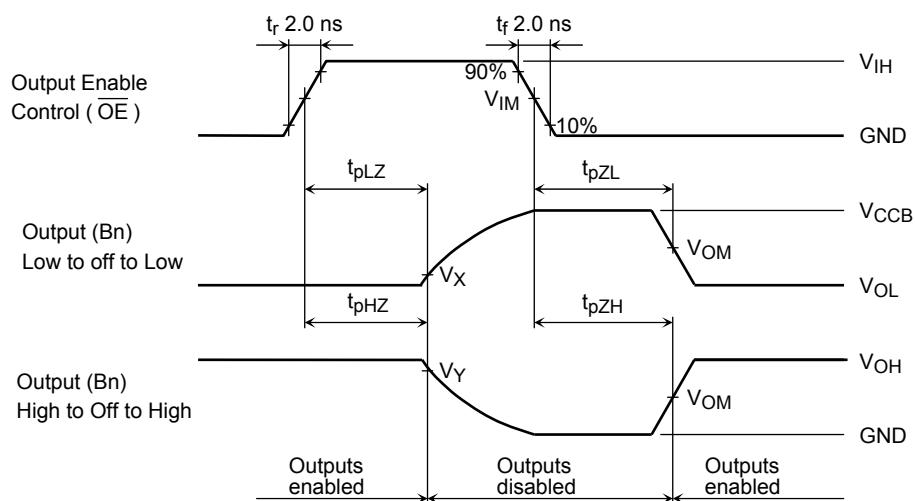


Parameter	Switch
t _{pLH} , t _{pHL}	Open
t _{pLZ} , t _{pZL}	V _{CCB}
t _{pHZ} , t _{pZH}	GND

Symbol	V _{CCB} (output)	
	3.3 ± 0.3 V	1.8 ± 0.15 V
R _L	1 kΩ	1 kΩ
C _L	30 pF	30 pF

Figure 1

AC Waveform

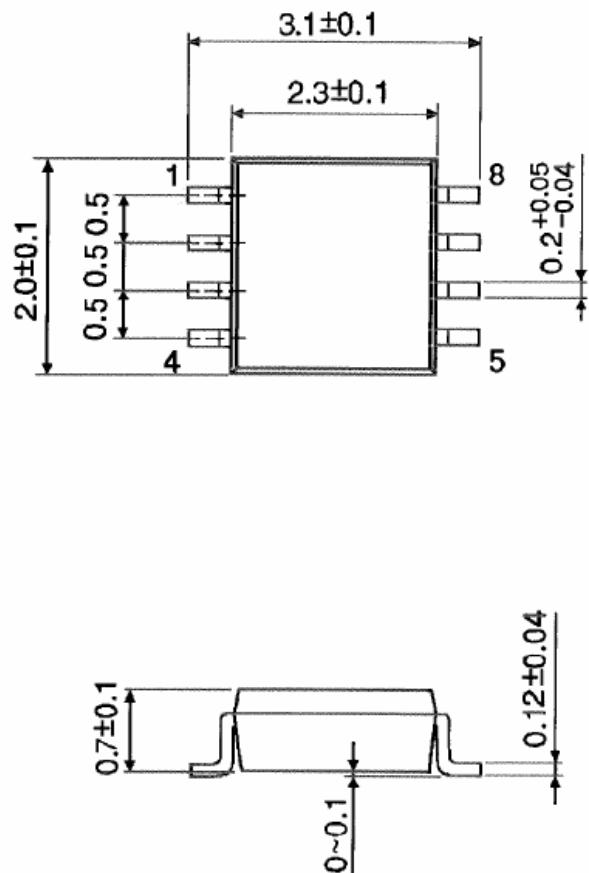
Figure 2 t_{PLH} , t_{PHL} Figure 3 t_{PLZ} , t_{PHZ} , t_{PZL} , t_{PZH}

	Symbol	V _{CCA} , V _{CCB}		
		3.3 ± 0.3 V	2.5 ± 0.2 V	1.5 ± 0.1 V
Input	V _{IH}	-	V _{CCA}	V _{CCA}
	V _{IM}	-	V _{CCA} /2	V _{CCA} /2
Output	V _{OM}	V _{OH} /2	V _{OH} /2	-
	V _X	V _{OL} + 0.3 V	V _{OL} + 0.15 V	-
	V _Y	V _{OH} - 0.3 V	V _{OH} - 0.15 V	-

Package Dimensions

SSOP8-P-0.50A

Unit : mm

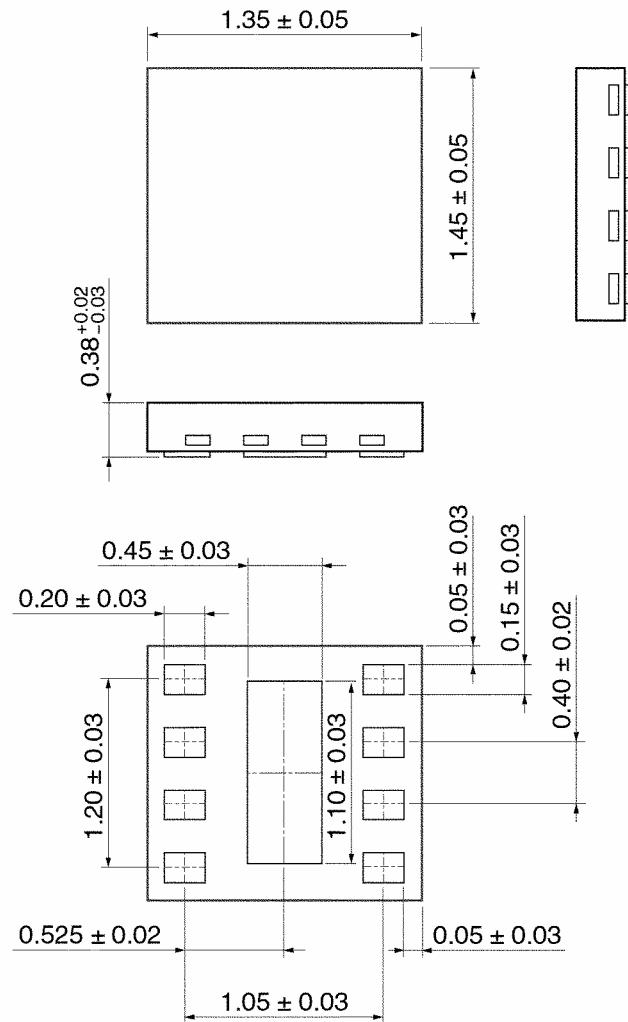


weight: 0.01 g (typ.)

Package Dimensions

CSON8-P-0.4

Unit: mm



Weight: 0.002 g (typ.)

RESTRICTIONS ON PRODUCT USE

20070701-EN GENERAL

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